



Report No.: OT-192-RWD-041

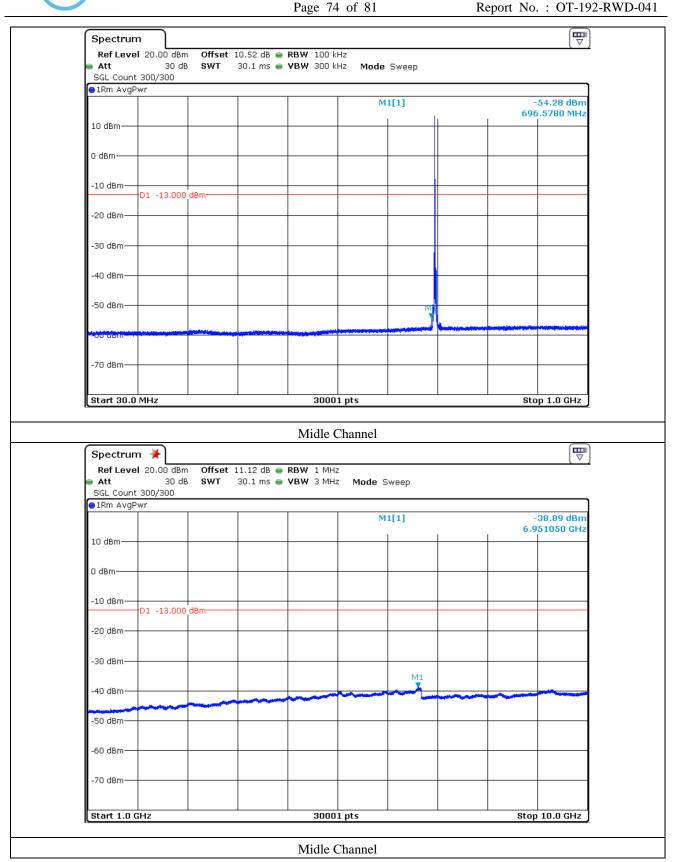


14.5.4 Test data for LTE Band 12 16QAM  $\blacksquare$ Spectrum Ref Level 20.00 dBm Offset 10.52 dB 🖷 RBW 100 kHz Att 30 dB SWT 30.1 ms 🁄 **VBW** 300 kHz Mode Sweep SGL Count 300/300 ●1Rm AvgPwr M1[1] -55.42 dBn 690.7230 MHz 10 dBm-0 dBm--10 dBm--20 dBm--30 dBm--40 dBm--50 dBm· -70 dBm-Start 30.0 MHz Stop 1.0 GHz 30001 pts Low Channel Spectrum Offset 11.12 dB • RBW 1 MHz Ref Level 20.00 dBm 30 dB 30.1 ms 

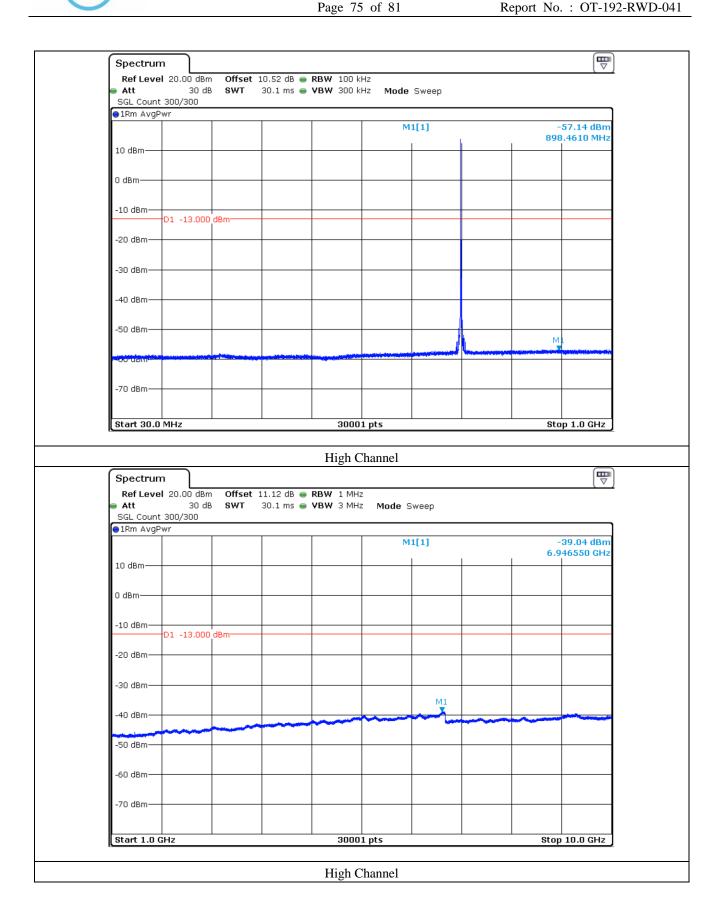
VBW 3 MHz Att SWT Mode Sweep SGL Count 300/300 ●1Rm AvgPwr M1[1] -38.95 dBm 6.961250 GHz 10 dBm-0 dBm-D1 -13.000 dBm--20 dBm--30 dBm--40 dBm--50 dBm--60 dBm--70 dBm-Start 1.0 GHz 30001 pts Stop 10.0 GHz

Low Channel











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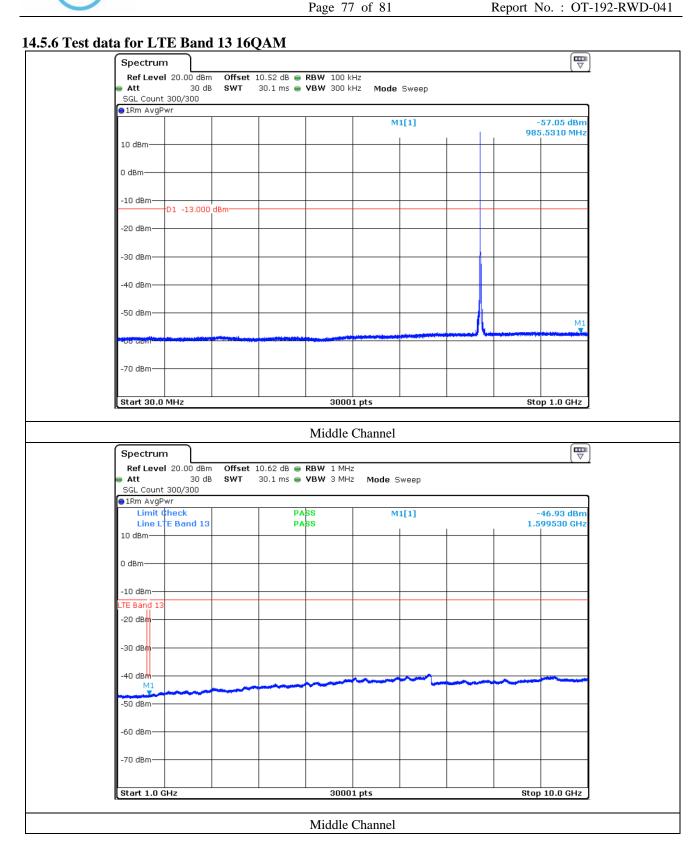


14.5.5 Test data for LTE Band 13 QPSK  $\blacksquare$ Spectrum Ref Level 20.00 dBm Offset 10.52 dB 🖷 RBW 100 kHz Att 30 dB SWT 30.1 ms 🁄 **VBW** 300 kHz Mode Sweep SGL Count 300/300 ●1Rm AvgPwr M1[1] -50.00 dBm 771.9130 MHz 10 dBm-0 dBm--10 dBm--20 dBm--30 dBm--40 dBm--50 dBm· -70 dBm-Start 300.0 MHz Stop 1.0 GHz 30001 pts Low Channel Spectrum Offset 10.62 dB @ RBW 1 MHz Ref Level 20.00 dBm 30 dB **SWT** 30.1 ms 🁄 **VBW** 3 MHz Att Mode Sweep SGL Count 300/300 ●1Rm AvgPwr Limit Check Line LTE Band 13 M1[1] -47.15 dBm 1.600130 GHz 10 dBm-0 dBm--10 dBm--20 dBn -30 dB -40 dB -50 dBm· -60 dBm--70 dBm-Start 1.0 GHz 30001 pts Stop 10.0 GHz

Low Channel









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## 15. FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE

## 15.1 Operating environment

Temperature : 23 °C

Relative humidity : 47 % R.H.

#### 15.2 Test set-up

1. Frequency Stability (Voltage Variation)

+20 °C temperature and  $\pm 15\%$  supply voltage variations. If a product is specified to operate over a range of input voltage then the -15% variation is applied to the lowermost voltage and the +15% is applied to the uppermost voltage.

- (1) Vary primary supply voltage from ±15% of the nominal value for other than hand carried battery equipment.
- (2) For hand carried, battery powered equipment, reduce primary supply voltage to the battery-operating end point which shall be specified by the manufacturer.
- 2. Frequency Stability (Temperature Variation)

Turn EUT off and set chamber temperature to -30 °C and then allow sufficient time (approximately 20 to 30 minutes after chamber reach the assigned temperature) for EUT to stabilize. Turn ON EUT and measure the EUT operating frequency and then turn off the EUT after the measurement. The temperature in the chamber was raised 10 °C step from -30 °C to +50 °C. Repeat above method for frequency measurements every 10 °C step and then record all measured frequencies on each temperature step.

#### 15.3 Test equipment used

	Model Number	Manufacturer	Description	Serial Number	Last Cal.
■ -	FSV30	Rohde & Schwarz	Signal Analyzer	101372	Aug. 23, 2018 (1Y)
■ -	AAMCS-UDC	AA-MCS	Directional Coupler	400	Aug. 23, 2018 (1Y)
■	MT8821C	ANRITSU	Radio Communication Analyzer	6261849029	Aug. 22, 2018 (1Y)
■ -	PSL-2KP	ESPEC	Environmental Test Chamber	14009407	Feb. 22, 2019 (1Y)
<b>I</b> -	PWS-3003D	Protek	DC Power Supply	4020409	Aug. 24, 2018 (1Y)

All test equipment used is calibrated on a regular basis.





#### 15.4 Test data

15.4.1 Test data for Voltage(V)\_LTE Band 4

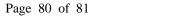
Temperature( ° C)	Power(VDC)	Center Freq.	Measured Freq.	PPM
	12.0		1 732 500 009	0.005 2
20	10.2	1 732 500 000	1 732 500 011	0.006 3
	13.8		1 732 500 008	0.004 6

15.4.2 Test data for Temperature( ° C) \_LTE Band 4

Temperature( ° C)	Power(VDC)	Center Freq.	Measured Freq.	PPM
-30			1 732 499 996	-0.002 3
-20			1 732 499 995	-0.002 9
-10			1 732 499 991	-0.005 2
0			1 732 500 003	0.001 7
10	12.0 V	1 732 500 000	1 732 500 006	0.003 5
20			1 732 500 009	0.005 2
30			1 732 500 007	0.004 0
40			1 732 500 009	0.005 2
50			1 732 500 011	0.0063

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Report No.: OT-192-RWD-041





15.4.3 Test data for Voltage(V)\_LTE Band 12

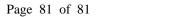
Temperature( ° C)	Power(VDC)	Center Freq.	Measured Freq.	PPM
	12.0		707 500 006	0.008 5
20	10.2	707 500 000	707 500 008	0.011 3
	13.8		707 499 991	-0.012 7

# 15.4.4 Test data for Temperature( $^{\circ}$ C) \_LTE Band 12

Temperature( ° C)	Power(VDC)	Center Freq.	Measured Freq.	PPM
-30			707 500 014	0.019 8
-20			707 500 011	0.015 5
-10			707 499 993	-0.009 9
0			707 499 995	-0.007 1
10	12.0 V	707 500 000	707 500 009	0.012 7
20			707 500 006	0.008 5
30			707 500 010	0.014 1
40			707 499 994	-0.008 5
50			707 499 998	-0.002 8

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Report No.: OT-192-RWD-041





15.4.5 Test data for Voltage(V)\_LTE Band 13

Temperature( ° C)	Power(VDC)	Center Freq.	Measured Freq.	PPM
	12.0		781 999 987	-0.016 6
20	10.2	782 000 000	781 999 985	-0.019 2
	13.8		781 999 988	-0.015 3

## 15.4.6 Test data for Temperature( $^{\circ}$ C) \_LTE Band 13

Temperature( ° C)	Power(VDC)	Center Freq.	Measured Freq.	PPM
-30			781 999 984	-0.020 5
-20			781 999 987	-0.016 6
-10			781 999 982	-0.023 0
0			782 000 006	0.007 7
10	12.0 V	782 000 000	781 999 998	-0.002 6
20			781 999 997	-0.003 8
30			781 999 992	-0.010 2
40		781 999 994	781 999 994	-0.007 7
50			781 999 996	-0.005 1

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